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Date:Mar. 31, 2003

**Product Name:** 

PANEL PC

Model Number:

Onyx-158-B1, Onyx-158D-B1, Onyx-158E-B1,

Onyx-158S-B1, Onyx-158SD-B1, Onyx-158SE-B1

Applicant:

AAEON Technology Inc.

5F, No. 135, Lane 235, Pao Chiao Rd., Hsin-Tien City, Taipei, Taiwan, R.O.C.

Date of Receipt:

03/11/2003

Finished date of Test:

03/20/2003

Applicable Standards:

**Immunity Emission** 

EN 55011:1998 Group 1 Class A

+A2:1998

EN 61000-3-2:1995+A1:1998

EN 61000-3-3:1995+A1:1998

EN 50082-1:1997

- IEC 61000-4-2:1995+A1:1998

- IEC 61000-4-3:1995+A1:1998

- ENV 50204:1995

- IEC 61000-4-4:1995

- IEC 61000-4-5:1995

- IEC 61000-4-6:1996

- IEC 61000-4-8:1993

- IEC 61000-4-11:1994

We. Spectrum Research & Testing Laboratory Inc., hereby certify that one sample of the above was tested in our laboratory with positive results according to the above-mentioned standards. The records in the report are an accurate account of the results. Details of the results are given in the subsequent pages of this report.

Checked By:

(Sunyou Chen)

Approved By:

( Johnson Ho, Director )

Lab Code: 200099-0



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#### 1. DOCUMENT POLICY AND TEST STATEMENT

#### 1.1 DOCUMENT POLICY

- The report shall not be reproduced except in full, without the written approval of SRT Lab, Inc.
- The report must not be used by the applicant to claim that the product is endorsed by NVLAP.
- The NVLAP logo applies only to the applicable standards specified in this report.

#### 1.2 TEST STATEMENT

- The test results in the report apply only to the unit tested by SRT Lab.
- There was no deviation from the requirements of test standards during the test.
- AC power source, 230 VAC/50 Hz, was used during the test.



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#### 2. DESCRIPTION OF EUT AND TEST MODE

#### 2.1 GENERAL DESCRIPTION OF EUT

PRODUCT	PANEL PC				
MODEL NO.	Onyx-158-B1, Onyx-158D-B1, Onyx-158E-B1, Onyx-158S-B1, Onyx-158SD-B1, Onyx-158SE-B1				
POWER SUPPLY	100-240V, 47-63Hz				
CABLE N/A					

#### NOTE:

The EUT has six model numbers as below on market. They are identical in all aspects except for the following :

Model No.	Glass	With Speaker port
Onyx-158-B1	Glass	NO
Onyx-158D-B1	Dynapro Resistive	NO
Onyx-158E-B1	ELO Resistive	NO
Onyx-158S-B1	Glass	YES
Onyx-158SD-B1	Dynapro Resistive	YES
Onyx-158SE-B1	ELO Resistive	YES

The model: Onyx-158SD-B1 was chosen as the representative for testing.

For more detailed information, please refer to the EUT's specification or user's manual provided by manufacturer.

#### 2.2 DESCRIPTION OF EUT INTERNAL DEVICE

DEVICE	BRAND / MAKER	MODEL#	FCC ID/DOC	REMARK
M/B	AAEON	PCM-6898	N/A	
CPU	INTEL	PENTIUM III 850MHz	N/A	
HDD	IBM	IC25 N020ATCS04-0	DOC	
POWER SUPPLY	POWER ADD	PPS100-31	DOC	
FDD	NEC	FD3238T	DOC	
CD ROM NEC		CD-2800E	DOC	
PANEL	FUJISTU	FLC38XGC6V-06	DOC	



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#### 2.3 DESCRIPTION OF TEST MODE

The EUT was pre-tested under the following video resolution: 640x480, 800x600, 1024x768.

The worst emission was found under 1024x768 and therefore the test data of only this mode is recorded.

#### 3. DESCRIPTION OF APPLIED STANDARDS

The EUT could be used in industrial environment information provided by the applicant, it must comply with the requirements of the following standards:

EN 55011:1998 Group 1 Class A

EN 61000-3-2:1995+ A1:1998+A2:1998

EN 61000-3-3:1995+A1:1998

EN 50082-1:1999

- IEC 61000-4-2:1995+A1:1998

- IEC 61000-4-3:1995+A1:1998

- ENV 50204:1995

- IEC 61000-4-4:1995

- IEC 61000-4-5:1995

- IEC 61000-4-6:1996

- IEC 61000-4-8:1993

- IEC 61000-4-11:1994

All tests have been performed and recorded as the above standards.



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#### 4. EMISSION TEST

#### 4.1 CONDUCTED EMISSION TEST FOR POWER PORT

#### 4.1.1 CONDUCTED EMISSION LIMIT

FREQUENCY (MHz)	Class A	(dBμV)	Class B (dBμV)		
TILQULITOT (MITZ)	Quasi-peak	Average	Quasi-peak	Average	
0.15 - 0.5	79	66	66 - 56	56 - 46	
0.5 - 5.0	73	60	56	46	
5.0 - 30.0	73	60	60	50	

#### **NOTE:**

- 1. The lower limit shall apply at the transition frequencies.
- 2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

#### **4.1.2 TEST EQUIPMENT**

The following test equipment was used for the test:

EQUIPMENT/ FACILITIES	SPECIFICATIONS	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
EMI TEST	9 kHz TO 30 MHz	ROHDE &	ESHS30/	JUL. 2003
RECEIVER	9 KHZ TO 30 MHZ	SCHWARZ	826003/008	R&S
LISN	FO uld FO ohm	SOLAR	8012-50-R-24-BNC	JUN. 2003
LISIN	50 μH, 50 ohm	ELECTRONICS	/ 924839	ETC
LICNI	50::II 50 -l	SOLAR	9252-50-R-24-BNC	JUN. 2003
LISN	50μH, 50 ohm	ELECTRONICS	/ 951318	ETC

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

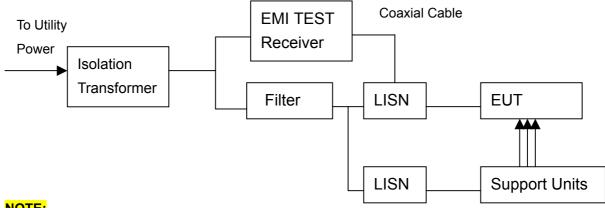


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#### 4.1.3 TEST SETUP



### NOTE:

- 1. The EUT was put on a wooden table with 0.8m height above ground plane, and 0.4m away from reference ground plane (> 2mx2m).
- 2. For the actual test configuration, please refer to the photos of testing.

#### 4.1.4 TEST PROCEDURE

The EUT was tested according to the requirement of EN 55011:1998 Group 1 Class A. The frequency spectrum from 0.15 MHz to 30 MHz was investigated. The LISN used was 50 ohm/50uH as specified. All readings were quasi-peak and average values with 10 kHz resolution bandwidth of the test receiver. The EUT system was operated in all typical methods by users. Both lines of the power mains of EUT were measured and the cables connected to EUT and support units were moved to find the maximum emission levels for each frequency.



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#### 4.1.5 DESCRIPTION OF SUPPORT UNIT

The EUT was configured by the requirement of EN 55011. All interface ports were connected to the appropriate support units via specific cables. The support units and cables are listed below.

NO	DEVICE	BRAND	MODEL#	CABLE
1	MONITOR	SAMSUNG	PG17IS	1.5m unshielded power cord 1.2m shielded data cable
2	PRINTER	EPSON	STYLUS C20SX	1.5m unshielded power cord 1.2m shielded data cable
3	MODEM	ACEEX	DM-1414	1.5m unshielded DC power cable 1.2m shielded data cable
4	KEYBOARD	ACER	6311-TA	1.2m unshielded data cable
5	MOUSE	LOGITECH	M-S34	1.2m unshielded data cable
6	USB MOUSE	HP	MO19UCA	1.8m unshielded data cable
7	USB MOUSE	HP	MO19UCA	1.8m unshielded data cable
8	COM MOUSE	LOGITECH	M-M35	1.8m unshielded data cable
9	WALKMAN	AIWA	HS-P102	1.5m unshielded data cable
10	JOYSTICK	LOGITECH	J-YG8	1.8m unshielded data cable

**NOTE:** For the actual test configuration, please refer to the photos of testing.

#### 4.1.6 EUT OPERATING CONDITION

- 1. Under WINDOWS 98 ran "EMI TEST" and "WinFcc" program. PC sent "H" pattern or accessed the following peripherals:
  - Color Monitor
  - RS232
  - Keyboard
  - Mouse
  - Printer
  - FDD
  - HDD
- 2. Under WINDOWS 98 ran "Media Play" program.



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#### 4.1.7 TEST RESULT

Temperature: 20 °C Humidity: 59 %RH
Ferquency Range: 0.15 – 30 MHz Test Mode: N/A

Receiver Detector: Q.P. and AV. Tested By: Alen Chou

Power Line Measured : Line

Freq.	Correct. Factor	Reading Value (dBμV)		Emission Level (dBμV)			nit μV)		gin B)
(33332)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
0.200	0.20	43.8	1	44.0	-	79.0	66.0	-35.0	N/A
0.536	0.20	31.6	1	31.8	-	73.0	60.0	-41.2	N/A
0.939	0.20	27.2	1	27.4	-	73.0	60.0	-45.6	N/A
2.060	0.20	26.6	1	26.8	-	73.0	60.0	-46.2	N/A
3.841	0.28	28.7	1	29.0	-	73.0	60.0	-44.0	N/A
7.610	0.36	29.6	-	30.0	-	73.0	60.0	-43.0	N/A

Power Line Measured: Neutral

Freq. (MHz)	Correct. Factor	Reading Value (dBμV)		lue Emission Level (dBμV)			nit μV)	Mar (d	gin B)
,	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
0.150	0.20	45.7	-	45.9	-	79.0	66.0	-33.1	N/A
0.540	0.20	31.5	-	31.7	-	73.0	60.0	-41.3	N/A
0.607	0.20	30.7	-	30.9	-	73.0	60.0	-42.1	N/A
1.278	0.20	27.7	-	27.9	-	73.0	60.0	-45.1	N/A
2.626	0.20	28.0	_	28.2	-	73.0	60.0	-44.8	N/A
7.923	0.36	29.2	_	29.6	-	73.0	60.0	-43.4	N/A

#### NOTE:

- 1. Measurement uncertainty is 2dB
- 2. Emission level = Reading valus + Correction factor
- 3. Correction Factor = Cable loss + Insertion loss of LISN
- 4. Margin value = Emission level Limit
- 5. The emission of other frequencies were very low against the limit.
- 6. "-": The Quasi-peak reading value also meets average limit and measurement with the average detector is unnecessary.



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#### 4.2 RADIATED EMISSION TEST

#### 4.2.1 RADIATED EMISSION LIMIT

EN 55011:1998 Group 1 limits of radiated emission measurement for frequency below 1000 MHz

FREQUENCY (MHz)	Class A (at 10m)	Class B (at 10m)
TREQUERCT (WITZ)	dBμV/m	dBμV/m
30 – 230	40	30
230 - 1000	47	37

#### NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level (dB $\mu$ V/m) = 20 log Emission level ( $\mu$ V/m).

#### **4.2.2 TEST EQUIPMENT**

The following test equipment was used during the radiated emission test:

EQUIPMENT/ FACILITIES	SPECIFICATIONS	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
EMI TEST	9 kHz TO	ROHDE &	ESCS30/	AUG. 2003
RECEIVER	2750 MHz	SCHWARZ	830245/012	R&S
BI-LOG	25 MHz TO	EMCO	3142/	APR. 2003
ANTENNA	2 GHz	EMCO	9701-1124	ETC
OATS	3 – 10 M	SRT	SRT-1	MAY 2003
UAIS	MEASUREMENT	SKI	SKI-I	SRT

#### NOTE:

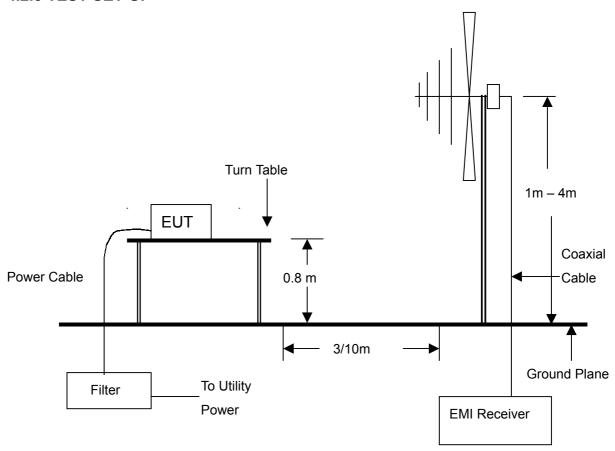
- 1. The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. The Open Area Test Site (SRT-1) is registered by FCC with No. 90957 and VCCI with No. R-1081.
- 3. The Open Area Test Site (SRT-2) is registered by FCC with No. 98458 and VCCI with No. R-1168.



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#### 4.2.3 TEST SET-UP



#### **NOTE:**

- 1. The EUT system was put on a wooden table with 0.8m heights above a ground plane.
- 2. For the actual test configuration, please refer to the photos of testing.

#### **4.2.4 TEST PROCEDURE**

The EUT was tested according to the requirement of EN 55011:1998 Group 1 Class A. The measurements were made at an open area test site with 10 meter measurement distance. The frequency spectrum measured from 30 MHz to 1 GHz. All readings were quasi-peak values with 120 kHz resolution bandwidth of the test receiver. The EUT system was operated in all typical methods by users. The cables connected to EUT and support units were moved to find the maximum emission levels for each frequency.



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#### 4.2.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### **4.2.6 EUT OPERATING CONDITION**

Same as section 4.1.6 of this report.



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#### 4.2.7 TEST RESULT

Temperature: 20 °C Humidity: 59 %RH

Ferquency Range: 30 – 1000 MHz Measured Distance: 10m

Receiver Detector: Q.P. or AV. Tested by Alen Chou

Antenna Polarization: Horizontal

Frequency (MHz)	Cable Loss (dB)	Antenna Factor (dB/m)	Reading Data (dBµV)	Emission Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	AZ(°)	EL (m)
69.6188	1.04	7.15	12.6	20.8	40.0	-19.2	320.3	4.0
154.2001	1.52	8.72	16.5	26.7	40.0	-13.3	169.5	4.0
166.3515	1.58	8.96	14.5	25.0	40.0	-15.0	272.6	4.0
182.2366	1.61	10.48	17.8	29.9	40.0	-10.1	253.1	4.0
462.5994	2.88	17.31	11.8	32.0	47.0	-15.0	51.2	1.32
518.6722	3.33	18.96	20.0	42.3	47.0	-4.7	339.0	2.15

Antenna Polarization: Vertical

Frequency (MHz)	Cable Loss (dB)	Antenna Factor (dB/m)	Reading Data (dBµV)	Emission Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	AZ(°)	EL (m)
49.0620	1.10	9.49	14.8	25.4	40.0	-14.6	110.1	1.0
135.1892	1.39	7.60	18.6	27.6	40.0	-12.4	166.8	1.0
196.2532	1.61	10.10	14.9	26.6	40.0	-13.4	211.1	1.0
210.2707	1.67	10.10	20.5	32.3	40.0	-7.7	256.1	1.0
434.5618	2.52	16.68	18.6	37.8	47.0	-9.2	0	1.0
616.7993	3.14	20.90	11.2	35.5	47.0	-11.5	252.1	1.81

#### NOTE:

- 1. Measurement uncertainty is 4dB.
- 2. "\*": Measurement does not apply for this frequency.
- 3. Emissiom Level = Reading Value + Ant. Factor + Cable Loss.
- 4. The field strength of other emission frequencies were very low against the limit.



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#### 4.3 CURRENT HARMONICS TEST

#### 4.3.1 LIMIT

For Class A Equipment

EVEN HARMONICS		ODD HARMONICS		
HARMONICS ORDER	LIMIT (Amp.)	HARMONICS ORDER	LIMIT (Amp.)	
2	1.08	3	2.30	
4	0.43	5	1.14	
6	0.30	7	0.77	
8 < n < 40	0.23 x 8 / n	9	0.40	
		11	0.33	
		13	0.21	
		15 < n < 39	0.15 x 8 / n	

#### For Class D Equipment

Harmonics Order	Max. permissible harmonics	Max. permissible harmonics		
n	current per watt (mA/W)	current (A)		
Odd Harmonics only				
3	3.4	2.30		
5	1.9	1.14		
7	1.0	0.77		
9	0.5	0.40		
11	0.35	0.33		
13	0.30	0.21		
15 ≤ n ≤ 39	3.85 / n	0.15 x 15 / n		

#### NOTE:

- 1. Class A and Class D are judged by test equipment automatically as per Section 5 of EN 61000-3-2:1995
- 2. The above limits for Class D equipment are for all applications having an active input power > 75 W. No limits apply for equipment with an active input power up to and including 75 W.



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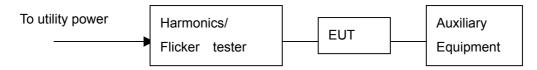
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#### **4.3.2 TEST EQUIPMENT**

EQUIPMENT /	MANUFACTURER	MODEL#/	DUE DATE OF CAL.
FACILITIES		SERIAL#	& CAL. CENTER
MAIN UNIT	HP	6842A/ 3734A00212	MAR. 2003 AGILENT

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

#### 4.3.3 TEST SETUP



#### NOTE:

- 1. The EUT system was put on a wooden table with 0.8m high.
- 2. For the actual test configuration, please refer to the photos of testing.

#### **4.3.4 TEST PROCEDURE**

According to EN61000-3-2

#### 4.3.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### **4.3.6 EUT OPERATING CONDITION**

Same as section 4.1.6 of this report.



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#### 4.3.7 TEST RESULT

55% RH Temperature: 20 °C Humidity: **Fundamental Current:** 0.64 A Max. Power Voltage: 227.79Vrms Consumption: 68.26W Power Factor: 0.466 Tested mode: N/A Tested by: Ken Su Test Result: **PASS** 

Because the power of EUT was below 75W, so the EUT didn't need be tested.



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#### 4.4 VOLTAGE FLUCTUATIONS

#### 4.4.1 LIMIT

Short-team flicker ( $P_{st}$ ): 1.0 Long-term flicker ( $P_{lt}$ ): 0.65

Relative steady-state voltage change (D<sub>c</sub>) : ≤ 3%

Relative voltage change characteristic (D (t) ) > 3%;  $(T_{D(t)})$ :  $\leq$  200 ms

Maximum relative voltage change (D<sub>max</sub>) : ≤ 4%

TEST ITEM	LIMIT	NOTE	
P <sub>st</sub>	1.0	P <sub>st</sub> means short-term flicker indicator.	
P <sub>lt</sub>	0.65	P <sub>lt</sub> means long-term flicker indicator.	
T <sub>D(t)</sub> (ms)	200	$T_{D(t)}$ means maximum time that D (t) exceeds 3 %.	
D <sub>max</sub> (%)	4%	D <sub>max</sub> means maximum relative voltage change.	
D <sub>c</sub> (%)	3%	D <sub>c</sub> means relative steady-state voltage change	

#### **4.4.2 TEST EQUIPMENT**

EQUIPMENT /	MANUFACTURER	MODEL#/	DUE DATE OF CAL.
FACILITIES		SERIAL#	& CAL. CENTER
MAIN UNIT	HP	6842A/ 3734A00212	MAR. 2003 AGILENT

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

#### 4.4.3 TEST PROCEDURE

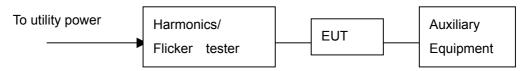
According to EN 61000-3-3



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#### 4.4.4 TEST SETUP



**NOTE**: 1. The EUT system was put on a wooden table with 0.8m high.

2. For the actual test configuration, please refer to the photos of testing.

#### 4.4.5 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### **4.4.6 EUT OPERATING CONDITION**

Same as section 4.1.6 of this report.



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#### 4.4.7 TEST RESULT

20 °C Humidity: Temperature: 55% RH Input Voltage: Observation 227.85Vrms Period: 1Hr Ampere: 0.64 Arms Power Factor: 0.466 Tested mode: N/A Tested by: Ken Su Test Result: **PASS** 

#### Test Result:

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	TEST RESULT
P <sub>st</sub>	0.09	1.0	PASS
P <sub>lt</sub>	0.00	0.65	PASS
T <sub>D(t)</sub> (ms)	0.01	200	PASS
D <sub>max</sub> (%)	0.00	4%	PASS
D <sub>c</sub> (%)	0.00	3%	PASS

#### NOTE:

- 1. P<sub>st</sub> means short-term flicker indicator.
- 2. P<sub>lt</sub> means long-term flicker indicator.
- 3.  $T_{D(t)}$  means maximum time that D(t) exceeds 3 %.
- 4. D<sub>max</sub> means maximum relative voltage change.
- 5. D<sub>c</sub> means relative steady-state voltage change.
- 6. N/A: Not applicable.



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#### 5. ELECTROSTATIC DISCHARGE IMMUNITY TEST

#### **5.1 TEST EQUIPMENT**

EQUIPMENT /	MANUFACTURER	MODEL # /	DUE DATE OF CAL.
FACILITIES		SERIAL #	& CAL. CENTER
ESD SIMULATOR	NOISEKEN	ESS-100L(A)/TC-815P/ 8099C02238/7099C02	NOV. 2003 FTC

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

#### 5.2 TEST PROCEDURE

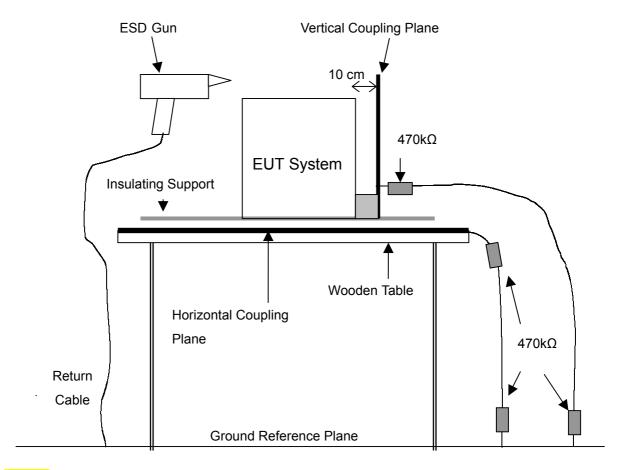
According to IEC/EN 61000-4-2



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#### 5.3 TEST SET-UP



#### NOTE:

- 1. The wooden table should be 0.8m high for table top EUT and 0.1m for floor-standing EUT.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. A distance of 1m minimum was provided between EUT and walls / other metallic structure.



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#### 5.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### 5.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.

#### 5.6 TEST CONDITION AND PERFORMANCE CRITERION

1. Test condition

(1) R-C Network :330  $\Omega$ , 150 pF (2) Test level: Air Discharge : $\pm 2kV$ ,  $\pm 4kV$ ,  $\pm 8kV$ 

Contact discharge : ±2kV, ±4kV HCP discharge : ±2kV, ±4kV VCP discharge : ±2kV, ±4kV

(3) Discharge mode : Single discharge

(4) Discharge period : at least 1 s

(5) Discharge polarity : Positive and Negative

(6) Number of discharge : Minimum 50 times at each test point of contact

discharge and at least 200 times of discharge to EUT in total. Minium 10 times at each test area

of air discharge selected.

2. Standard requirement : Criterion B

3. Performance criterion

(1) Criterion A Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function or

performance which requires operator

intervention system reset



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# 5.7 SUMMARY OF TEST RESULT

Temperature:	22°C	Humidity:	49% RH	
Test Result:	Criterion A pass	Tested by:	Alen Chou	

SEVERITY	COI	TEST OBSERVAT	ION	
LEVEL	AIR DISCHARGE	CONTACT DISCHARGE	НСР	VCP
±2kV	Α	Α	Α	Α
±4kV	А	А	А	Α
±8kV	А	NR	NR	NR

#### **NOTE:**

Description of test observation:

A: There was no change compared with initial operation during the test.

NR: No requirement

### **Description of test points:**

- 1. Panel.
- 2. Power LED on front side of EUT.
- 3. Speaker switch on front side of EUT.
- 4. Seams of enclosure of EUT.
- 5. Rack on back side of EUT.
- 6. Bracket of M/B.
- 7. Game port of M/B.
- 8. Enclosure of EUT.
- 9. Metal brackets on rear side of EUT.
- 10. Screws of EUT enclosure.



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#### 6. RADIATED IMMUNITY TEST

#### **6.1 TEST EQUIPMENT**

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
SIGNAL	HP	8648A/	JUN. 2003
GENERATOR		3636A022776	ETC
ANITENINIA	SCHAFFNER	CBL6111/	JUL. 2003
ANTENNA	CHASE	1188	SRT
FIELD SENSOR	AMPLIFIER	FP2000/	DEC. 2003
FIELD SENSOR	RESEARCH	28499	ETC
POWER	AMPLIFIER	100W1000M1/	JUN. 2003
AMPLIFIER	RESEARCH	19509	ETC
ANECHOIC	CDT	A05/	SEP. 2003
CHAMBER	SRT	SRT005	SRT

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

#### 6.2 TEST PROCEDURE

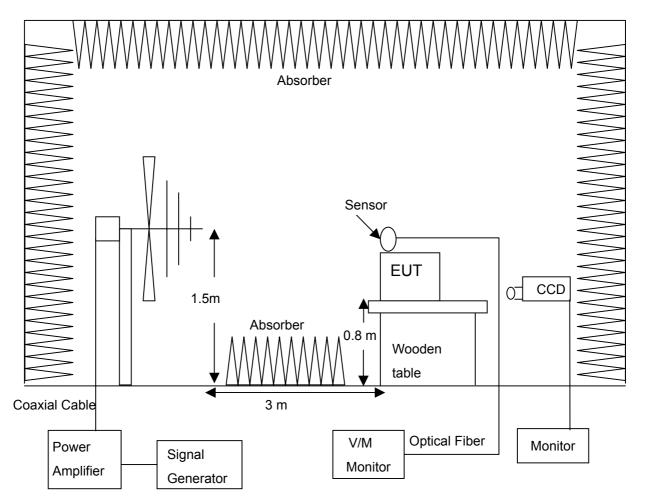
According to IEC/EN 61000-4-3



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#### 6.3 TEST SETUP



#### NOTE:

- 1. The wooden table should be 0.8m high for table top EUT and 0.1m for floor-standing EUT.
- 2. For the actual test configuration, please refer to the photos of testing.

#### 6.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

## 6.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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#### 6.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency : 230V/50Hz, single phase

(2) Sweeping frequency : 80MHz – 1 GHz

(3) Test level : 10V/m, the frequncy step is 1%

(4) The four sides of EUT are tested : front, rear, left, right

(5) Modulation : 80%AM, 1kHz Dwell time for each

frequency at least 3sec..

(6) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

#### 6.7 TEST RESULT

Temperature:24°CHumidity:53% RHTest Result:Criterion A passTested by:Alen Chou

FREQUENCY	LEVEL	MODULATION	DIRECTION	TEST RESULT (CRITERION)
80MHz - 1GHz	3V/m	80%AM, 1kHz	FRONT	Α
80MHz - 1GHz	3V/m	80%AM, 1kHz	REAR	А
80MHz - 1GHz	3V/m	80%AM, 1kHz	LEFT	А
80MHz - 1GHz	3V/m	80%AM, 1kHz	RIGHT	А

#### NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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#### 7. RADIATED IMMUNITY TEST

#### 7.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
SIGNAL	HP	8648A/	JUN. 2003
GENERATOR		3636A022776	ETC
ANITENINIA	SCHAFFNER	CBL6111/	JUL. 2003
ANTENNA	CHASE	1188	SRT
FIELD SENSOR	AMPLIFIER	FP2000/	DEC. 2003
FIELD SENSOR	RESEARCH	28499	ETC
POWER	AMPLIFIER	100W1000M1/	JUN. 2003
AMPLIFIER	RESEARCH	19509	ETC
ANECHOIC	CDT	A05/	SEP. 2003
CHAMBER	SRT	SRT005	SRT

**NOTE:** The calibration interval of the above test equipment is one year and the calibrations are traceable to NML/ROC and NIST/USA.

#### 7.2 TEST PROCEDURE

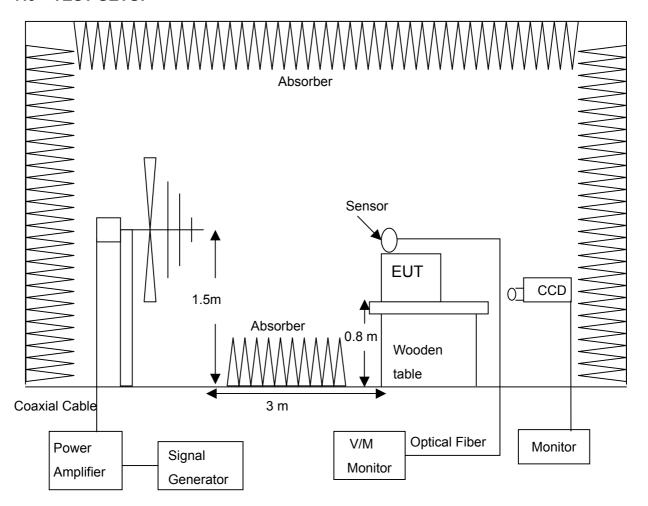
According to ENV 50204



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#### 7.3 TEST SETUP



#### NOTE:

- 1. The wooden table should be 0.8m high for table top EUT and 0.1m for floor-standing EUT.
- 2. For the actual test configuration, please refer to the photos of testing.

#### 7.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

## 7.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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#### 7.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency : 230V/50Hz, single phase

(2) Sweeping frequency : 900 MHz +/-5 MHz

(3) Test level : 10V/m, the frequncy step is 1%

(4) The four sides of EUT are tested : front, rear, left, right

(5) Modulation : 50% duty cycle(1Hz), 200Hz pluse Dwell

time for each frequency at least 1sec..

(6) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

#### 7.7 TEST RESULT

Test Mode: N/A Tested by: Alen Chou	Temperature:	24°C	Humidity:	53% RH	
	Test Mode:	N/A	Tested by:	Alen Chou	

Test Result: Criterion A pass

FREQUENCY	LEVEL	MODULATION	DIRECTION	TEST RESULT (CRITERION)
900MHz +/-5MHz	3V/m	50%pulse, 1Hz	FRONT	Α
900MHz +/-5MHz	3V/m	50%pulse, 1Hz	REAR	Α
900MHz +/-5MHz	3V/m	50%pulse, 1Hz	LEFT	А
900MHz +/-5MHz	3V/m	50%pulse, 1Hz	RIGHT	А

#### **NOTE:**

Description of test observation:

A: There was no change compared with initial operation during the test.



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#### 8. ELECTRICAL FAST TRANSIENT / BURST IMMUNITY TEST

#### 8.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL # / SERIAL #	DUE DATE OF CAL & CAL CENTER
EFT GENERATOR	HAEFELY	PEFT-JUNIOR / 583-333-122	NOV. 2003 ETC

#### 8.2 TEST PROCEDURE

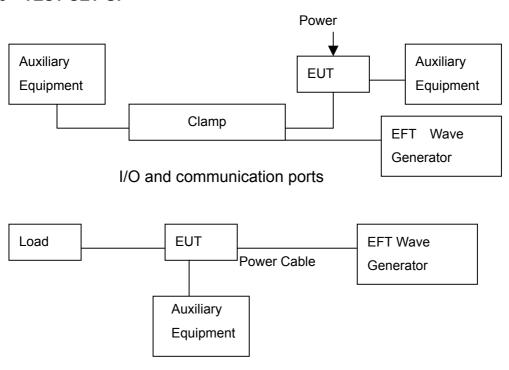
According to IEC/EN 61000-4-4



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#### 8.3 TEST SET-UP



Power supply ports

#### NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height for table top EUT and 0.1m for floor-standing EUT above ground reference plane.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. The minimum distance between the EUT and all other conductive structure was more than 0.5m.
- 4. The minimum distance between the coupling plates of the coupling clamps (if used) and all over conductive structures, except the ground plane beneath the coupling clamp and beneath the EUT was more than 0.5m.
- 5. The power cable connecting EUT was controlled under 1m.

#### 8.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### 8.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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#### 8.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency: 230V/50Hz, single phase

(2) Pulse risetime and duration : 5ns / 50ns (3) Pulse repetition : 5kHz

(4) Polarity : Positive Polarization and Negative

Polarization

(5) Burst duration and period : 15ms / 300ms(6) Test duration : ≥ 61sec each line

(7) Time between test : 10Sec

(8) Severity levels : Power Line ±1kV

Signal/Control Line ±0.5kV

(9) Standard requirement : Criterion B

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

#### 8.7 SUMMARY OF TEST RESULT

Temperature:	25°C	Humidity:	55% RH
Test Mode:	N/A	Tested by:	Alen Chou

Test Result : Criterion B pass

Voltage		0.5kV		1kV		
Polarity		+	-	+	-	
Test	L1	Α	Α	В	В	
	L2	Α	Α	В	В	
Line	GND	Α	Α	В	В	
Lille	Signal/ Control Line	N/A	N/A	N/A	N/A	

#### NOTE:

Description of test observation:

B: Installed USB mouse again during the test.

N/A: Not applicable, as the signal/control line used in typical is less than 3 m.



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#### 9. SURGE TEST (POWER LINE)

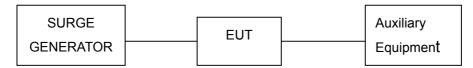
#### 9.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
SURGE TEST	SCHAFFNER	NSG 2050 /	OCT. 2003
(System Mainframe)	SCHAFFINER	199904-057SC	ETC
SURGE TEST	CCHAFFNED	PNW 2050 /	OCT. 2003
(Impulse Network)	SCHAFFNER	256	ETC
SURGE TEST	CCHAFFNED	CDN 131/133 /	OCT. 2003
(Pulse Coupling Network)	SCHAFFNER	520	ETC

#### 9.2 TEST PROCEDURE

According to IEC/EN 61000-4-5

#### 9.3 TEST SET-UP



#### NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height above ground reference plane.
- 2. For the actual test configuration, please refer to the photos of testing.

#### 9.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

#### 9.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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#### 9.6 TEST CONDITION / PERFORMANCE CRITERIA

1		Test	conc	liti∩n
	٠.	ICOL	COLIC	

(1) Test level : Common mode : ±0.5kV, ±1kV, ±2kV

Differential mode: ±0.25kV, ±0.5kV, ±1kV

(2) Pulse : 5

(3) Phase : 0°, 90°, 180°, 270°, 359°

(4) Polarity : Positive and Negative polarization

(5) Repetition : 60 s

(6) Waveform : 1.2/50 µs (open circuit)

(7) Standard requirement : Criterion B

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

#### 9.7 SUMMARY OF TEST RESULT

Temperature:	21°C	Humidity:	57% RH
Test Mode:	N/A	Tested by:	Alen Chou

Test Result : Criterion A pass

Mode	Coupling	Voltage	Phase				
wode Coupling		Voltage	0°	90°	180°	270°	359°
	L + PE	+/-0.5kV	Α	Α	Α	Α	Α
Common N + PE L · N + PE	+/-1kV	Α	Α	Α	Α	Α	
	L、N + PE	+/-2kV	Α	Α	Α	Α	Α
		+/-0.25kV	А	Α	Α	А	Α
Differential	L + N	+/-0.5kV	Α	Α	Α	Α	Α
		+/-1kV	Α	Α	Α	Α	Α

#### NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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# 10. INDUCED RF FIELDS (CONDUCTED SUSCEPTIBILITY) TEST

## **10.1 TEST EQUIPMENT**

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
EM INJECTION CLAMP	FCC	F-203I-23mm/ 110	MAY 2003 ETC
POWER LINE CDN	FCC	FCC-801-M4-32A/ 9808	MAY 2003 ETC
POWER LINE CDN	FCC	FCC-801-M5-32A/ 9812	MAY 2003 ETC
POWER LINE CDN	FCC	FCC-801-M1-32A/ 9820	MAY 2003 ETC
SIGNAL LINE CDN	FCC	FCC-801-T2/ 9830	MAY 2003 ETC
SIGNAL LINE CDN	FCC	FCC-801-T4/ 9831	MAY 2003 ETC
SIGNAL LINE CDN	FCC	FCC-801-T6/ 9832	MAY 2003 ETC
SIGNAL LINE CDN	FCC	FCC-801-S9/ 9843	MAY 2003 ETC
POWER LINE CDN	FCC	FCC-801-M2-32A/ 9840	NOV. 2003 ETC
SIGNAL GENERATOR	HP	8648A/ 3636A02776	JUN. 2003 ETC
POWER AMPLIFIER	A.R.	150A100A/ 19553	MAY 2003 ETC
DUAL DIRECTION COULPER	A.R.	DC2600/ 25893	JUN. 2003 ETC
POWER METER	BOONTON	4232A/ 29001	MAY 2003 ETC
SIGNAL LINE CDN	FCC	FCC-801-S25/ 9845	MAY 2003 ETC
POWER LINE CDN	FCC	FCC-801-M3-32A/ 9874	MAY 2003 ETC

## 10.2 TEST PROCEDURE

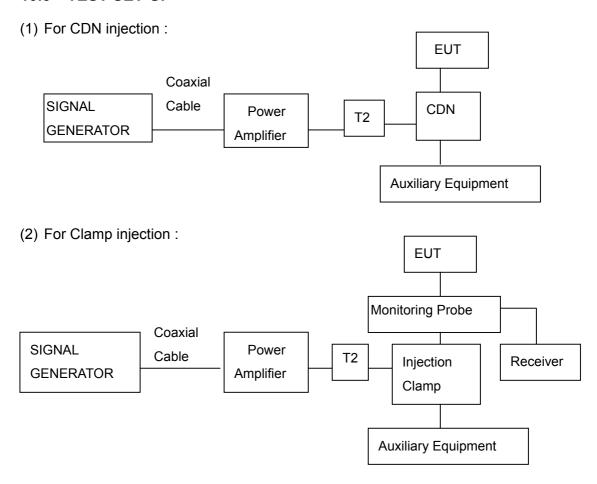
According to IEC/EN 61000-4-6



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#### 10.3 TEST SET-UP



#### NOTE:

- 1. The EUT system was put on a wooden table with 0.1m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing.
- 3. The distance between CDN(Clamp) and EUT was controlled between 0.1m and 0.3m.

### 10.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

### 10.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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### 10.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency : 230 V/ 50 Hz, single phase

(2) Sweeping frequency : 150 kHz – 80 MHz

(3) Test level : 3 V, the frequency step is 1% (4) Polarity : Positive and Negative polarization

(5) Modulation : AM 80%, 1 kHz
 (6) Dwell time for each frequency : at least 3 s
 (7) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

### 10.7 SUMMARY OF TEST RESULT

Temperature:	24°C	Humidity:	55% RH
Test Mode:	N/A	Tested by:	Alen Chou

Test Result : Criterion A pass

FREQUENCY	LEVEL	MODULATION	INJECTION METHOD	TEST RESULT (CRITERION)
150kHz - 80MHz	3V	80% AM, 1 kHz	М3	Α

#### NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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## 11. POWER FREQUENCY MAGNETIC-FIELD TEST

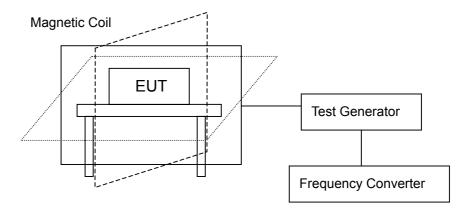
### 11.1 TEST EQUIPMENT

EQUIPMENT /	MANUFACTURER	MODEL#/	DUE DATE OF CAL.
FACILITIES		SERIAL#	& CAL. CENTER
MAGNETIC FIELD TESTER	HAEFELY	MAG 100.1/ 080.015-04	JAN. 2004 ETC
MAGNETIC FIELD	F.W.BELL	4080/	MAR. 2003
METER		19990416	ITRI

### 11.2 TEST PROCEDURE

According to IEC/EN 61000-4-8

### 11.3 TEST SET-UP



### NOTE:

- 1. The EUT system was put on a wooden table with 0.8m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing

## 11.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.



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#### 11.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.

#### 11.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Test axis : X, Y and Z axes (2) Test time : 5 min / each axis

(3) Field strength : 3 A/m(4) Standard requirement : Criterion A

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function

or performance which is self-recoverable

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset

## 11.7 SUMMARY OF TEST RESULT

Temperature:	24°C	Humidity:	55% RH
Test Mode:	N/A	Tested by:	Alen Chou

Test Result: Criterion A pass

ORIENTATION	FIELD STRENGTH	TEST RESULT (CRITERION)
X	3 A/m	Α
Υ	3 A/m	A
Z	3 A/m	A

## NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.



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## 12. VOLTAGE DIPS, INTERRUPTS, VARIATIONS TEST

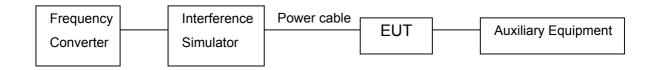
### 12.1 TEST EQUIPMENT

EQUIPMENT / FACILITIES	MANUFACTURER	MODEL#/ SERIAL#	DUE DATE OF CAL. & CAL. CENTER
INTERFERENCE	HAFFELY	PLINE 1610/	JUN. 2003
SIMULATOR	HACFELI	083-732-05	ETC

## 12.2 TEST PROCEDURE

According to IEC/EN 61000-4-11

## 12.3 TEST SET-UP



#### NOTE:

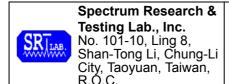
- 1. The EUT system was put on a wooden table with 0.8m height above ground.
- 2. For the actual test configuration, please refer to the photos of testing.

### 12.4 DESCRIPTION OF SUPPORT UNIT

Same as section 4.1.5 of this report.

### 12.5 EUT OPERATING CONDITION

Same as section 4.1.6 of this report.



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### 12.6 TEST CONDITION / PERFORMANCE CRITERIA

1. Test condition

(1) Source voltage and frequency(2) Test level(3) Zest level(4) Zest level(5) Zest level(6) Zest level(7) Zest level(8) Zest level(9) Zest level(1) Zest level(2) Dip depth 30%, 0.5 period;

Dip depth 60%, 5, 50 period; interrupt 95%, 250 period.

(3) Phase : 0°, 180°

(4) Test duration : 2min each phase

(5) Time between test : 10 sec

(7) Standard requirement : Dip 30% : Criterion B pass; Dip 60% : Criterion C pass;

Interrupt > 95%: Criterion C pass

2. Performance criterion

(1) Criterion A : Normal performance during test

(2) Criterion B : Temporary degradation or loss of function or

performance which is self-recoverable.

(3) Criterion C : Temporary degradation or loss of function

or performance which requires operator

intervention system reset.

#### 12.7 SUMMARY OF TEST RESULT

Temperature:	21°C	Humidity:	57% RH
Test Result:	Pass	Tested by:	Alen Chou

AC POWER	DIP DEPTH	INTERVAL	DIP TIME	TEST TIME	PHASE	TEST RESULT (Criterion)
	30%	10 sec	0.5 period	2 min	0°	Α
30 /0	10 360	0.5 period	2 111111	180°	Α	
230V/50Hz	600/	10 000	5, 50	2 min	0°	Α
230 7/30112	750Hz 60% 10 sec period 2 min	180°	Α			
	>95%	10 000	250 period	d 2 min	0°	В
	(interrupt)	10 sec	250 period		180°	В

#### NOTE:

Description of test observation:

A: There was no change compared with initial operation during the test.

B: Reset automatically.



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## 13. PHOTOS OF TESTING

- Conducted test







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# - Radiated test







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## - Harmonics test



# - Voltage fluctuations test





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# - Electrostatic discharge immunity test



- Electrical fast transient / burst immunity test





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# - Radiated immunity test







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# -Surge test (power line)



- Inducted RF fields (conducted susceptibility) test





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# - Power frequency magnetic-field test



- Voltage dips, interrupts, variations test





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# 14. TERMS OF ABRIVATION

AV.	Average detection	
AZ(°)	Turn table azimuth	
Correct.	Correction	
EL(m)	Antenna height (meter)	
EUT	Equipment Under Test	
Horiz.	Horizontal direction	
LISN	Line Impedance Stabilization Network	
NSA	Normalized Site Attenuation	
Q.P.	Quasi-peak detection	
SRT Lab	Spectrum Research & Testing Laboratory, Inc.	
Vert.	Vertical direction	